

Search Notes

Application/Control No.

10/612,299

Examiner

Y. J. Han

Applicant(s)/Patent under
Reexamination

DINH ET AL.

Art Unit

2838

SEARCHED

Class	Subclass	Date	Examiner
323	255		
	256		
	259		
	262		
	264		
	340		
	344		
363	21.06		
	21.14		
	45		
	46		
	47		
	48		

See search report 7/05 JH
Search updated 4/06 JH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PLUS	9/05	JH